

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re patent application of:  
Dean, et al.

Atty. Docket No.: BU998062

Serial No.: 09/394,302

Group Art Unit: 2114

Filed: September 10, 1999

Examiner: Chu, Gabriel L.

For: BUILT-IN APPLICATION SPECIFIC INTEGRATED CIRCUIT IN-TRANSIT  
TEST SYSTEM

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**AMENDMENT UNDER 37 C.F.R. §1.312**

Mail Stop AF Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Prior to payment of the issue fee, please amend the claims as follows: